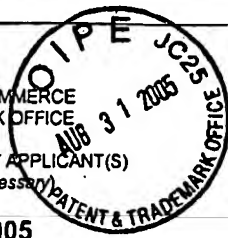


FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

ATTY. DOCKET NO.

01272.020625

APPLICATION NO.

10/649,872

APPLICANTS

SEIJI TAKAHASHI, ET AL.

FILING DATE

August 28, 2003

GROUP

2853

Date Submitted to PTO: August 31, 2005

U.S. PATENT DOCUMENTS

*EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
MS	62-9971	01/1987	JAPAN			ABSTRACT
MS	9-295412	11/1997	JAPAN			ABSTRACT
MS	10-250051	09/1998	JAPAN			ABSTRACT
MS	2000-58735	02/2000	JAPAN			ABSTRACT
MS	2000-229405	08/2000	JAPAN			ABSTRACT
MS	2001-138592	05/2001	JAPAN			ABSTRACT

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

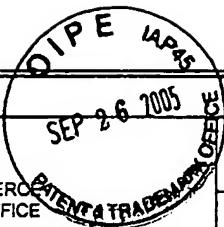
MS

DATE CONSIDERED

04 November 2005

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

MAW/tnt



Sheet 1 of 1		FORM PTO 1449 (modified)		ATTY. DOCKET NO. 01272.020625		APPLICATION NO. 10/649,872	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANTS SEIJI TAKAHASHI, ET AL.			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				FILING DATE August 28, 2003		GROUP 2853	
Date Submitted to PTO: September 26, 2005							
U.S. PATENT DOCUMENTS							
*EXAMINER'S INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		2001-58735	03/2001	JAPAN			ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER 				DATE CONSIDERED 04 November 2005			

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